

US PATENT DOCUMENTS							
Examiner Initial *			Name of Patentee or Applicant of cited Document	Class Subclass		Filing Date If Appropriate	
m	US-4775973	10/04/1988	Tomberlin, J., et al	<del>370</del>	60	10/22/1986	

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Substitute for form 1449A/PTO Complete if Known INFORMATION DISCLOSURE **Application Number** 10/039220 STATEMENT BY APPLICANT January 4, 2002 **Filing Date** Ko, Yiu Fai **First Named Inventor Group Art Unit** Unknown **Examiner Name** Unknown Attorney Docket No: 01365.060US1 Sheet 1 of 1

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po	US-6266514	07/24/2001	O'Donnell, O	455	<del>87.3</del>	11/06/1998	

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nu	WO-99/12228	03/11/1999	Watson, J R, et al	H01Q				

	OTHER DOCUMENTS NON PATENT LITERATURE DOCUMENTS					
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